February 2012 UniFET-II[™]



FDD5N50NZF N-Channel MOSFET 500V, 3.7A, 1.75Ω

Features

- $R_{DS(on)} = 1.47\Omega$ (Typ.) @ $V_{GS} = 10V$, $I_D = 1.85A$
- Low Gate Charge (Typ. 9nC)
- Low C_{rss} (Typ. 4pF)
- Fast Switching
- 100% Avalanche Tested
- Improved dv/dt Capability
- ESD Imoroved Capability
- RoHS Compliant

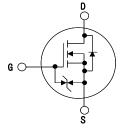


D



These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advance technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficient switching mode power supplies and active power factor correction.



MOSFET Maximum Ratings T_C = 25°C unless otherwise noted*

D-PAK

S

Symbol		FDD5N50NZF	Units		
V _{DSS}	Drain to Source Voltage			500	V
V _{GSS}	Gate to Source Voltage			±25	V
I _D	Drain Current	-Continuous ($T_C = 25^{\circ}C$)	-Continuous ($T_C = 25^{\circ}C$)		
		-Continuous (T _C = 100 ^o C)		2.2	A
I _{DM}	Drain Current	- Pulsed	- Pulsed (Note 1)		А
E _{AS}	Single Pulsed Avalanche Energy (Note		(Note 2)	165	mJ
I _{AR}	Avalanche Current		(Note 1)	3.3	А
E _{AR}	Repetitive Avalanche Energy		(Note 1)	6.25	mJ
dv/dt	Peak Diode Recovery dv/dt		(Note 3)	20	V/ns
P _D	Power Dissipation	$(T_{C} = 25^{\circ}C)$		62.5	W
		- Derate above 25°C		0.5	W/ºC
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C	
TL	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds			300	°C

Thermal Characteristics

Symbol	Parameter	FDD5N50NZF	Units	
$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case	2	°C/W	
$R_{ ext{ heta}JA}$	Thermal Resistance, Junction to Ambient	62.5	°C/W	

Device Marking Device FDD5N50NZF FDD5N50NZFTM		Device	Package	•	Reel Size	Таре	Width		Quantit	y
		D-PAK			6mm		2500			
Electrica	I Cha	racteristics T _c = :	25°C unless of	therwise not	ed					
Symbol		Parameter			st Conditions	s	Min.	Тур.	Max.	Units
Off Charac	teristic							.,,,,,	maxi	Unit
BV _{DSS}		o Source Breakdown Vo	Itage	lp = 250µA	$V_{00} = 0V$ To	= 25°C	500	_	-	V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breako	Breakdown Voltage Temperature		$I_D = 250\mu\text{A}, V_{GS} = 0\text{V}, T_C = 25^{o}\text{C}$ $I_D = 250\mu\text{A}, \text{ Referenced to } 25^{o}\text{C}$		-	0.5	-	V/°C	
				V _{DS} = 500V, V _{GS} = 0V			-	-	10	
IDSS				$V_{DS} = 400V, V_{GS} = 0V, T_C = 125^{\circ}C$			-	-	100	μA
I _{GSS}	Gate to Body Leakage Current			$V_{GS} = \pm 25V,$			-	-	±10	μΑ
On Charac	teristic	s								
V _{GS(th)}	Gate T	hreshold Voltage	,	V _{GS} = V _{DS} ,	_D = 250μA		3.0	-	5.0	V
R _{DS(on)}		Drain to Source On Resi		$V_{GS} = 10V, I$			-	1.47	1.75	Ω
9 _{FS}	Forwa	orward Transconductance		V _{DS} = 20V, I		(Note 4)	-	4.2	-	S
Dynamic C	haract	eristics								
C _{iss}	Input C	Capacitance			-	365	485	pF		
C _{oss}	Output	Capacitance		─ V _{DS} = 25V, V _{GS} = 0V f = 1MHz		-	50	65	pF	
C _{rss}	Revers	e Transfer Capacitance					-	4	8	pF
Q _{g(tot)}	Total G	ate Charge at 10V		$V_{DS} = 400 V I_D = 3.7 A$ $V_{GS} = 10 V$			-	9	12	nC
Q _{gs}	Gate to	Source Gate Charge				-	2	-	nC	
Q _{gd}	Gate to	to Drain "Miller" Charge		(Note 4, 5)		-	4	-	nC	
Switching	Charad	cteristics								
t _{d(on)}	-	n Delay Time					-	12	35	ns
t _r	Turn-O	n Rise Time		V _{DD} = 250V,		-	-	19	50	ns
t _{d(off)}	Turn-O	ff Delay Time	,	$V_{GS} = 10V, R_{GEN} = 25\Omega$ (Note 4, 1)			-	31	70	ns
t _f	Turn-O	ff Fall Time				(Note 4, 5)	-	22	55	ns
Drain-Sou	rce Dio	de Characteristics	5							
I _S	Maximum Continuous Drain to Source Diode Forward Current					-	-	3.7	Α	
I _{SM}	Maxim	um Pulsed Drain to Sour	ce Diode Forw	orward Current		-	-	14	Α	
V _{SD}	Drain to	o Source Diode Forward	Voltage	$V_{GS} = 0V, I_S$	_D = 3.7A		-	-	1.5	V
t _{rr}	Revers	e Recovery Time	,	$V_{GS} = 0V, I_{SD} = 3.7A$ $dI_F/dt = 100A/\mu s$		-	87	-	ns	
Q _{rr}	Revers	e Recovery Charge			(Note 4)	-	0.15	-	μC	

1. Repetitive Rating: Pulse width limited by maximum junction temperat

2. L = 23mH, I_{AS} = 3.7A, V_{DD} = 50V, R_G = 25 Ω , Starting T_J = 25°C

3. I_{SD} \leq 3.7A, di/dt \leq 200A/µs, V_{DD} \leq BV_{DSS}, Starting T_J = 25°C

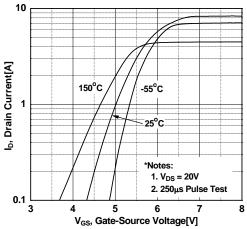
4. Pulse Test: Pulse width $\leq 300 \mu \text{s}, \, \text{Dual Cycle} \leq 2\%$

5. Essentially Independent of Operating Temperature Typical Characteristics

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Typical Performance Characteristics Figure 1. On-Region Characteristics 10 V_{GS} = 15.0 V 10.0 V 8.0 V 7.0 V 6.5 V I_b, Drain Current[A] l_b, Drain Current[A] 6.0 V 1 5.5 V 5.0 V 0.1 Notes 1. 250µs Pulse Test 2. $T_{C} = 25^{\circ}C$ 0.03 25 10 0.1 1 V_{DS}, Drain-Source Voltage[V] Figure 3. On-Resistance Variation vs. **Drain Current and Gate Voltage** 3.6 Reverse Drain Current [A] R_{DS(ON)} [Ω], $V_{GS} = 10V$ $V_{GS} = 20V$ <u>°</u> *Note: T_C = 25°C 1.2 0 2 4 6 8 10 I_D, Drain Current [A] **Figure 5. Capacitance Characteristics** 800 Ciss = Cgs + Cgd (Cds = shorted) $C_{OSS} = C_{dS} + C_{gd}$ Gate-Source Voltage [V] Crss = Cgd 600 Capacitances [pF] Ciss 400 *Note: Coss 1. $V_{GS} = 0V$ 2. f = 1MHz V_{GS}, 200 Crss 0 └ 0.1 30 10 1 V_{DS}, Drain-Source Voltage [V]

Figure 2. Transfer Characteristics





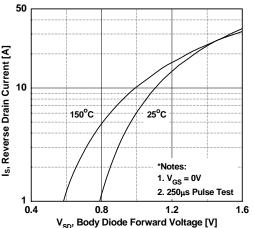
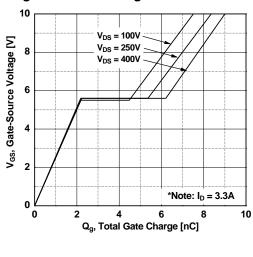
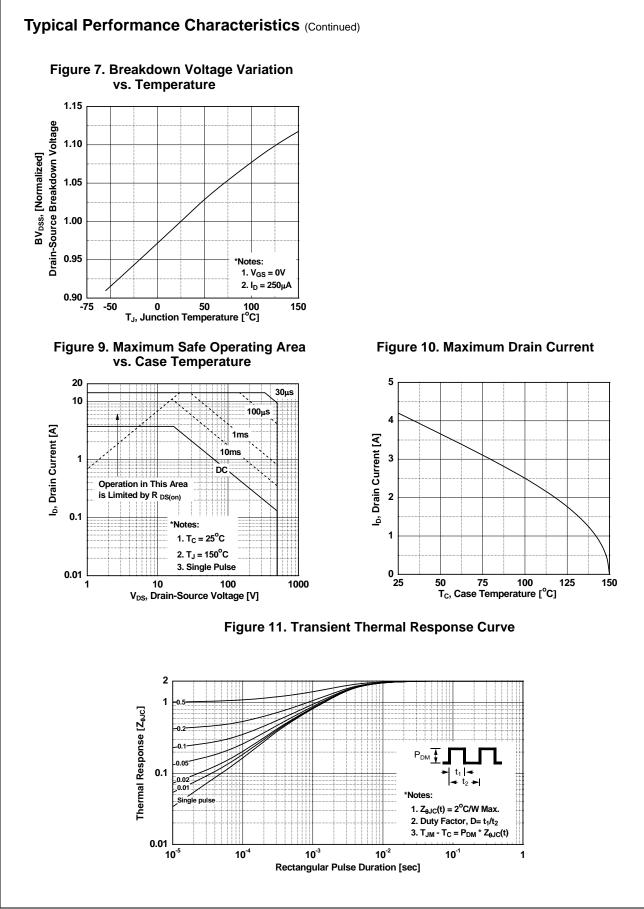
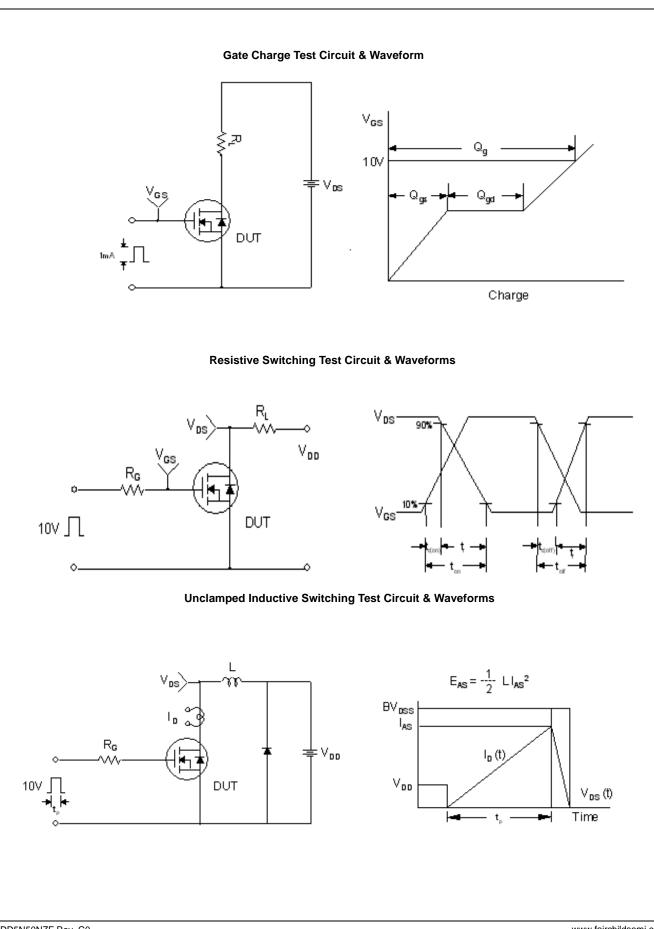


Figure 6. Gate Charge Characteristics

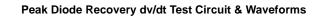


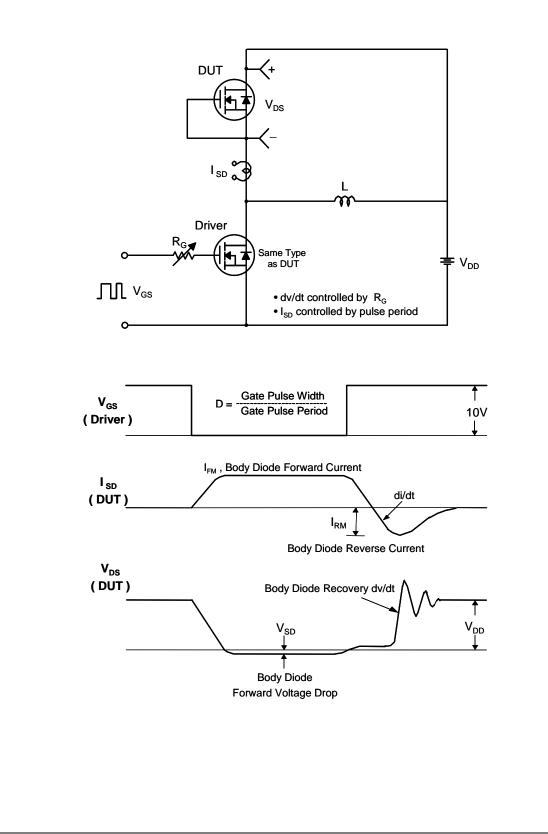


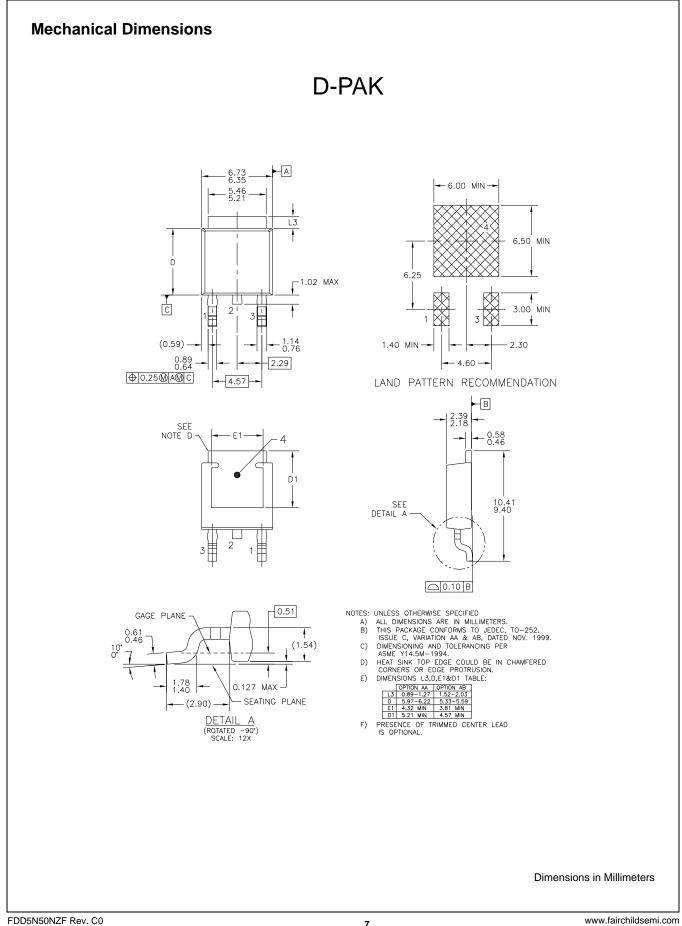
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